

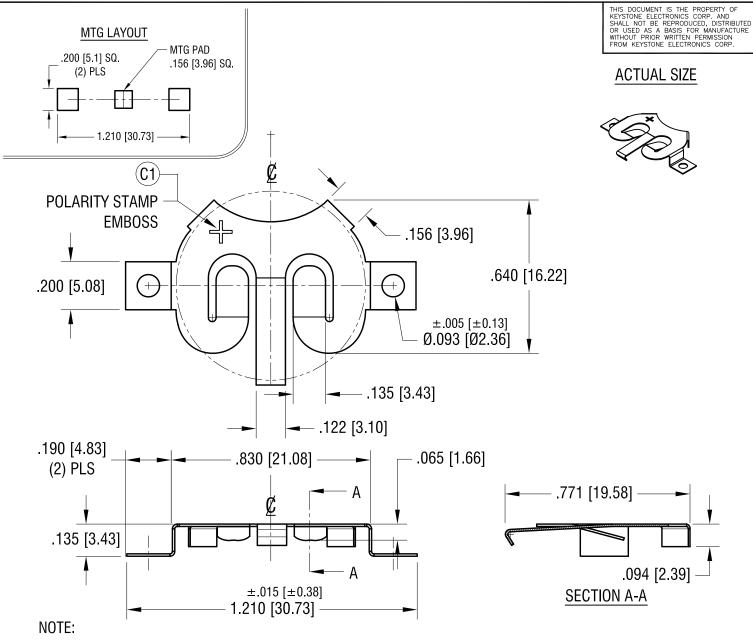
- 1. NO DISLODGMENT OF THE CELL OR DAMAGE TO RETAINER WITH THE FOLLOWING TESTS:
  - a) INTEGRITY VIBRATION TEST PER MIL-STD-810G METHOD 516.6
  - b) SHOCK TEST PER MIL-STD-810G METHOD 516.6
  - c) BENCH HANDLING SHOCK TEST PER MIL-STD 810G METHOD 516.6
  - d) TRANSIT DROP TEST PER MIL-STD 810G METHOD 516.6
- 2. TAPE AND REEL SPECIFICATIONS:
  - a) TAPE:

b) REEL:

MAT'L - ALL CONDUCTIVE POLYSTYRENE CARRIER ANSI/EIA-481 STANDARD

13.0 [330.2] DIA. 500 PIECES OF PART NO. 2898 PER REEL. 3.30.20 ECN 20-032 ADD NOTE 1. Α DATE **DESCRIPTION** REV.

KEYSTONE ELECTRONICS CORP. www.keyelco.com • NEW HYDE PARK, NY 11040 • Tel (516) 328-7500				
PART NAME				
CR2032 COIN CELL CLIP ON TAPE				
MATERIAL				
AS NOTED				
AS NOTED		DRN BY NT	9.19.18	
		APP'D RH	SCALE X	
TOLERANCES INCH [MM]	CODE	DWG NO.		
DECIMAL ± .015 [± 0.38] ANGULAR ± 1° UNLESS OTHERWISE SPECIFIED	С	2898TR		



- 1. NO DISLODGMENT OF THE CELL OR DAMAGE TO RETAINER WITH THE FOLLOWING TESTS:
  - a) INTEGRITY VIBRATION TEST PER MIL-STD-810G METHOD 516.6
  - b) SHOCK TEST PET MIL-STD-810G METHOD 516.6
  - c) BENCH HANDLING SHOCK TEST PER MIL-STD 810G METHOD 516.6
  - d) TRANSIT DROP TEST PER MIL-STD 810G METHOD 516.6

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STAMP (C1) WAS CUT THRU 1.11.23 CHANGE AS PER ECN 23-026		PART NAME	
	С	2032 COIN CELL SM RETAINER	
		MATERIAL	
	ADDED NOTE 1.		.010 [0.25] TH'K PHOSPHOR BRONZE
3.30.20	CHANGE AS PER ECN 20-031	В	FINISH DIATE DIATE ON BY NT DATE 9.19.18
	REMOVE DIMPLES		TIN NICKEL PLATE APP'D SCALE 2.5X
5.13.19	CHANGE AS PER ECN 19-053	A	TOLERANCES INCH [MM] CODE DWG NO.  DECIMAL ± .010 [± 0.25 ]
DATE	DESCRIPTION	REV.	ANGULAR ± 1° C 2898